

1-Mbit (64 K × 16) Static RAM

Features

■ Temperature Range

□ Automotive: -40 °C to 125 °C

■ High speed
□ t_{AA} = 15 ns

■ Optimized voltage range: 2.5 V to 2.7 V

■ Low active power: 220 mW (Max)

■ Automatic power-down when deselected

■ Independent control of upper and lower bits

■ CMOS for optimum speed/power

■ Available in Pb-free and non Pb-free 44-pin TSOP II, 44-pin (400-Mil) Molded SOJ and Pb-free 48-ball FBGA packages

Functional Description

The CY7C1021CV26 is a high-performance CMOS static RAM organized as 65,536 words by 16 bits. This device has an

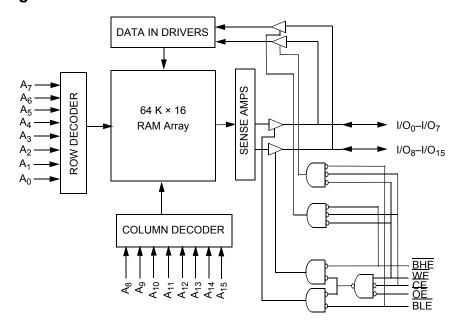
automatic power-down feature that significantly reduces power consumption when deselected.

Writing to the device is accomplished by taking Chip Enable (\overline{CE}) and Write Enable (\overline{WE}) inputs LOW. If Byte Low Enable (\overline{BLE}) is LOW, then data from I/O pins $(I/O_0$ through $I/O_7)$, is written into the location specified on the address pins $(A_0$ through $A_{15})$. If Byte High Enable (\overline{BHE}) is LOW, then data from I/O pins $(I/O_8$ through $I/O_{15})$ is written into the location specified on the address pins $(A_0$ through $A_{15})$.

Reading from the device is accomplished by taking Chip Enable $(\overline{\text{CE}})$ and Output Enable $(\overline{\text{OE}})$ LOW while forcing the Write Enable $(\overline{\text{WE}})$ HIGH. If Byte Low Enable $(\overline{\text{BLE}})$ is LOW, then data from the memory location specified by the address pins will appear on I/O_0 to I/O_7 . If Byte High Enable $(\overline{\text{BHE}})$ is LOW, then data from memory will appear on I/O_8 to I/O_{15} . See the truth table at the end of this data sheet for a complete description of Read and Write modes.

The input/output pins (I/O $_0$ through I/O $_{15}$) are placed in a high-impedance state when the device is deselected (CE HIGH), the outputs are disabled (OE HIGH), the BHE and BLE are disabled (BHE, BLE HIGH), or during a Write operation (CE LOW, and WE LOW).

Logic Block Diagram



CY7C1021CV26



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Selection Guide

Description [1]	-15	Unit
Maximum Access Time	15	ns
Maximum Operating Current	80	mA
Maximum CMOS Standby Current	10	mA

Pin Configuration

Figure 1. 44-pin SOJ/TSOP II [2]

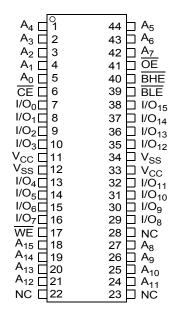
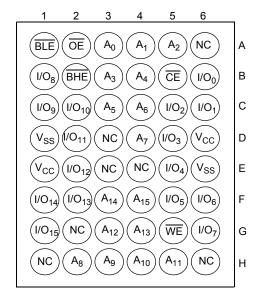


Figure 2. 48-ball FBGA Pinout [2]



Notes

^{1.} Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at V_{CC} = V_{CC(typ.)}, T_A = 25 °C.

^{2.} NC pins are not connected on the die.



Pin Definitions

Pin Name	Pin Number	I/O Type	Description
A ₀ -A ₁₅	1–5, 18–21, 24–27, 42–44	Input	Address Inputs used to select one of the address locations.
I/O ₀ –I/O ₁₅	7–10, 13–16, 29–32, 35–38	Input/Output	Bidirectional Data I/O lines. Used as input or output lines depending on operation.
NC	22, 23, 28	No Connect	No Connects. This pin is not connected to the die.
WE	17	Input/Control	Write Enable Input, active LOW . When selected LOW, a Write is conducted. When selected HIGH, a Read is conducted.
CE	6	Input/Control	Chip Enable Input, active LOW . When LOW, selects the chip. When HIGH, deselects the chip.
BHE, BLE	40, 39	Input/Control	Byte Write Select Inputs, active LOW. BHE controls I/O ₁₅ –I/O ₈ , BLE controls I/O ₇ –I/O ₀ .
ŌĒ	41	Input/Control	Output Enable, active LOW. Controls the direction of the I/O pins. When LOW, the I/O pins are allowed to behave as outputs. When de-asserted HIGH, I/O pins are tri-stated, and act as input data pins.
V _{SS}	12, 34	Ground	Ground for the device. Should be connected to ground of the system.
V _{CC}	11, 33	Power Supply	Power Supply inputs to the device.

[+] Feedback

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Maximum Ratings

DC input voltage ^[3]	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Current into outputs (LOW)	20 mA
Static discharge voltage(per MIL-STD-883, method 3015)	> 2001 V
Latch-up current	> 200 mA

Operating Range

Range	Ambient Temperature	V _{CC}	
Automotive	–40 °C to +125 °C	2.5 V-2.7 V	

Electrical Characteristics

Over the Operating Range

Doromotor	Description	Test Conditions	-1	Unit		
Parameter	Description	rest Conditions	Min	Max	Oille	
V _{OH}	Output HIGH voltage	V _{CC} = Min, I _{OH} = -1.0 mA	2.3	-	V	
V_{OL}	Output LOW voltage	V _{CC} = Min, I _{OL} = 1.0 mA	_	0.4	V	
V _{IH}	Input HIGH voltage		2.0	V _{CC} + 0.3	V	
V _{IL}	Input LOW voltage ^[3]		-0.3	0.8	V	
I _{IX}	Input leakage current	$GND \le V_I \le V_{CC}$	-3	+3	μΑ	
I _{OZ}	Output leakage current	$GND \le V_I \le V_{CC}$, output disabled	-3	+3	μΑ	
I _{CC}	V _{CC} operating supply current	V_{CC} = Max, I_{OUT} = 0 mA, f = f_{MAX} = 1/ t_{RC}	_	80	mA	
I _{SB1}	Automatic CE power-down Current —TTL inputs	Max V_{CC} , $\overline{CE} \ge V_{IH}$, $V_{IN} \ge V_{IH}$ or $V_{IN} \le V_{IL}$, $f = f_{MAX}$	_	15	mA	
I _{SB2}	Automatic CE power-down Current —CMOS inputs	$\begin{array}{l} \text{Max V}_{CC}, \overline{CE} \geq V_{CC} - 0.3 \text{ V}, V_{IN} \geq V_{CC} - 0.3 \text{ V}, \\ \text{or V}_{IN} \leq 0.3 \text{ V}, \text{ f} = 0 \end{array}$	_	10	mA	

Capacitance

Parameter [4]	Description	Test Conditions	Max	Unit
C _{IN}	Input capacitance	$T_A = 25 ^{\circ}\text{C}, f = 1 \text{MHz}, V_{CC} = 2.6 \text{V}$	8	pF
C _{OUT}	Output capacitance		8	pF

Thermal Resistance

Ī	Parameter [4]	Description	Test Conditions	44-pin TSOP II	Unit
	Θ_{JA}	,	Still Air, soldered on a 3 × 4.5 inch, four-layer	76.92	°C/W
ĺ	$\Theta_{\sf JC}$	Thermal Resistance (Junction to Case)	printed circuit board	15.86	°C/W

Notes

- 3. V_{IL} (min.) = -2.0V and V_{IH} (max) = V_{CC} + 0.5 V for pulse durations of less than 20 ns.
- 4. Tested initially and after any design or process changes that may affect these parameters.

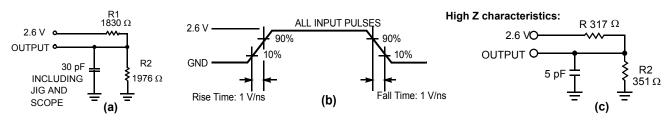
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AC Test Loads and Waveforms

Figure 3. AC Test Loads and Waveforms [5]



Switching Characteristics

Over the Operating Range

Parameter [6]	Description		15	I I mid					
Parameter	Description	Min	Max	Unit					
Read Cycle	Read Cycle								
t _{RC}	Read cycle time	15	_	ns					
t _{AA}	Address to data valid	-	15	ns					
t _{OHA}	Data hold from address change	3	_	ns					
t _{ACE}	CE LOW to data valid	-	15	ns					
t _{DOE}	OE LOW to data valid	_	7	ns					
t _{LZOE}	OE LOW to low Z ^[7]	0	_	ns					
t _{HZOE}	OE HIGH to high Z ^[7, 8]	_	7	ns					
t _{LZCE}	CE LOW to low Z ^[7]	3	_	ns					
t _{HZCE}	CE HIGH to high Z ^[7, 8]	_	7	ns					
t _{PU} ^[9]	CE LOW to power-up	0	_	ns					
t _{PD} ^[9]	CE HIGH to power-down	_	15	ns					
t _{DBE}	Byte enable to data valid	_	7	ns					
t _{LZBE}	Byte enable to low Z	0	_	ns					
t _{HZBE}	Byte disable to high Z	-	7	ns					

- 5. AC characteristics (except high Z) are tested using the Thevenin load shown in Figure 3 (a). High Z characteristics are tested for all speeds using the test load
- 6. Test conditions assume signal transition time of 2.6 ns or less, timing reference levels of 1.3 V, input pulse levels of 0 to 2.6 V.
- At any given temperature and voltage condition, t_{HZOE} is less than t_{LZOE}, t_{HZOE} is less than t_{LZOE}, and t_{HZWE} is less than t_{LZOE} for any given device.
 t_{HZOE}, t_{HZDE}, t_{HZDE}, t_{HZOE}, and t_{HZWE} are specified with a load capacitance of 5 pF as in part (c) of Figure 3. Transition is measured ±500 mV from steady-state voltage.
 This parameter is guaranteed by design and is not tested.



Switching Characteristics (continued)

Over the Operating Range

Parameter [6]	December 1	-15		11:0:4					
Parameter	Description	Min	Max	Unit					
Write Cycle ^[10]									
t _{WC}	Write cycle time	15	_	ns					
t _{SCE}	CE LOW to write end	10	_	ns					
t _{AW}	Address set-up to write end	10	-	ns					
t _{HA}	Address hold from write end	0	_	ns					
t _{SA}	Address set-up to write start	0	-	ns					
t _{PWE}	WE pulse width	10	-	ns					
t _{SD}	Data set-up to write end	8	_	ns					
t _{HD}	Data hold from write end	0	-	ns					
t _{LZWE}	WE HIGH to low Z ^[11]	3	_	ns					
t _{HZWE}	WE LOW to high Z ^[11, 12]	_	7	ns					
t _{BW}	Byte enable to end of write	9	-	ns					

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Notes

10. The internal Write time of the memory is defined by the overlap of CE LOW, WE LOW and BHE/BLE LOW. CE, WE and BHE/BLE must be LOW to initiate a Write, and the transition of these signals can terminate the Write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the Write.

11. At any given temperature and voltage condition, the load capacitance of 5 pF as in part (c) of Figure 3 on page 6. Transition is measured ±500 mV from steady-state voltage.



Switching Waveforms

Figure 4. Read Cycle No. 1 [13, 14]

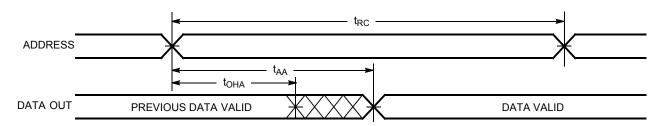
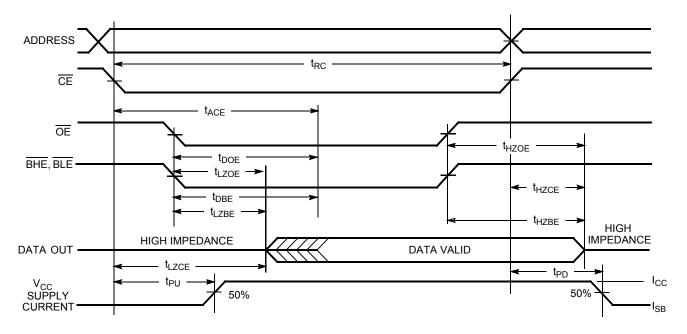


Figure 5. Read Cycle No. 2 ($\overline{\text{OE}}$ Controlled) [14, 15]



Notes

^{13.} Device is continuously selected. \overline{OE} , \overline{CE} , \overline{BHE} and/or $\overline{BLE} = V_{IL}$.

^{14.} WE is HIGH for Read cycle.

^{15.} Address valid prior to or coincident with $\overline{\text{CE}}$ transition LOW.



Switching Waveforms (continued)

Figure 6. Write Cycle No. 1 (CE Controlled) [16, 17]

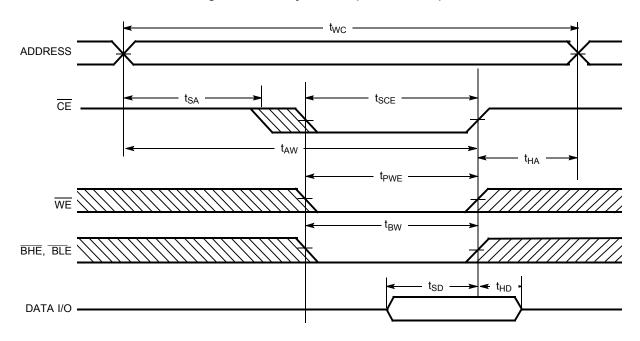
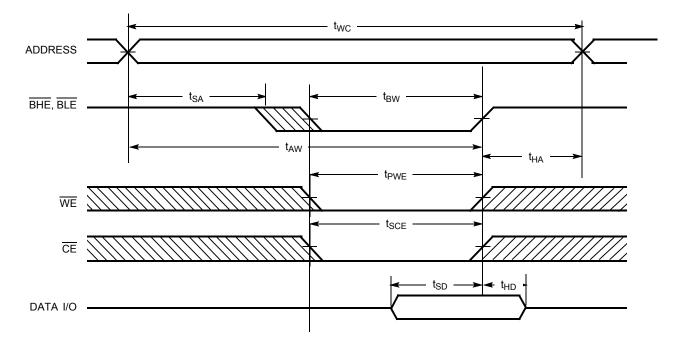


Figure 7. Write Cycle No. 2 (BLE or BHE Controlled)



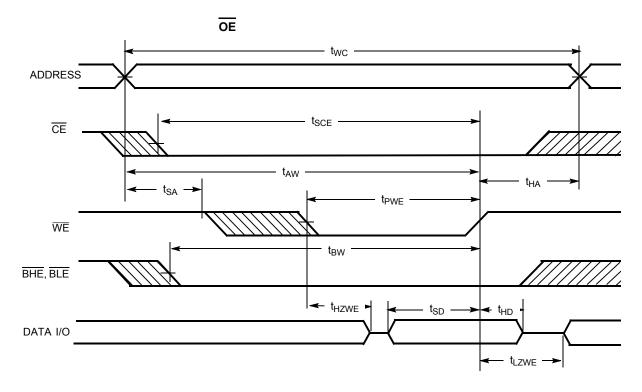
^{16.} Data I/O is high-impedance if OE or BHE and/or BLE= V_{IH}.

17. If CE goes HIGH simultaneously with WE going HIGH, the output remains in a high-impedance state.



Switching Waveforms (continued)

Figure 8. Write Cycle No. 3 (WE Controlled, LOW)



Truth Table

CE	OE	WE	BLE	BHE	I/O ₀ –I/O ₇	I/O ₈ –I/O ₁₅	Mode	Power
Н	Х	Х	X	X	High Z	High Z	Power-down	Standby (I _{SB})
L	L	Н	L	L	Data Out	Data Out	Read – All bits	Active (I _{CC})
			L	Н	Data Out	High Z	Read – Lower bits only	Active (I _{CC})
			Н	L	High Z	Data Out	Read – Upper bits only	Active (I _{CC})
L	Х	L	L	L	Data In	Data In	Write – All bits	Active (I _{CC})
			L	Н	Data In	High Z	Write – Lower bits only	Active (I _{CC})
			Н	L	High Z	Data In	Write – Upper bits only	Active (I _{CC})
L	Н	Н	Х	X	High Z	High Z	Selected, Outputs Disabled	Active (I _{CC})
L	Х	Х	Н	Н	High Z	High Z	Selected, Outputs Disabled	Active (I _{CC})



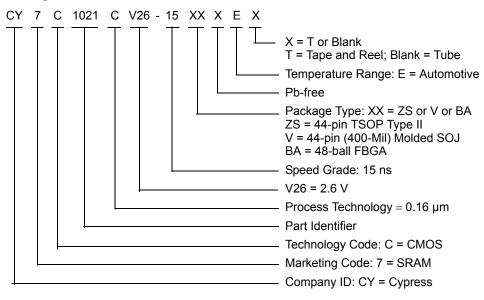
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Cypress offers other versions of this type of product in many different configurations and features. The following table contains only the list of parts that are currently available. For a complete listing of all options, visit the Cypress website at http://www.cypress.com/products or contact your local sales representative.

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Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
15	CY7C1021CV26-15ZSXE	51-85087	44-pin TSOP Type II (Pb-free)	Automotive
	CY7C1021CV26-15VXE	51-85082	44-pin (400-Mil) Molded SOJ (Pb-free)	
	CY7C1021CV26-15BAE	51-85150	48-ball FBGA (6 × 8 × 1 mm) (Pb-free)	
	CY7C1021CV26-15BAET	51-85150	48-ball FBGA (6 × 8 × 1 mm) (Pb-free)	
	CY7C1021CV26-15VXET	51-85082	44-pin (400-Mil) Molded SOJ (Pb-free)	
	CY7C1021CV26-15ZSXET	51-85087	44-pin TSOP Type II (Pb-free)	

Ordering Code Definitions



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Package Diagrams

Figure 9. 44-pin TSOP Z44-II, 51-85087

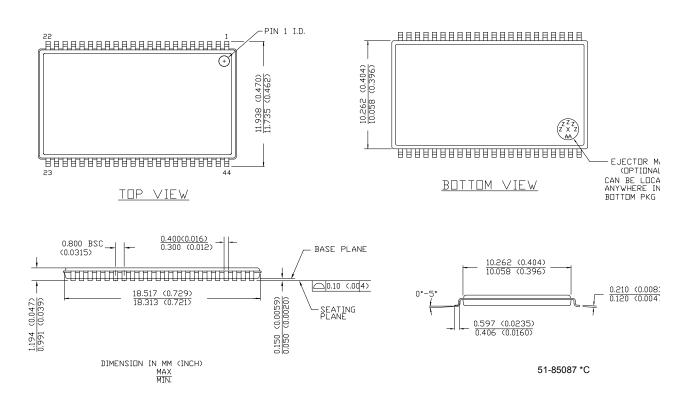
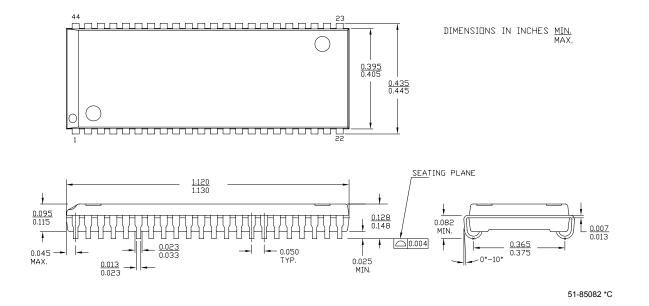


Figure 10. 44-pin Molded SOJ (400-Mil) V44.4, 51-85082

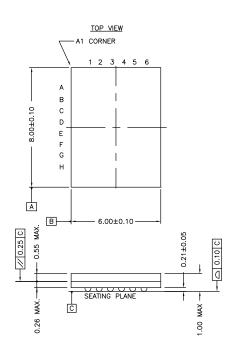


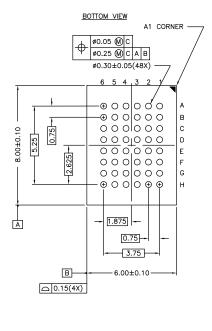
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Package Diagrams (continued)

Figure 11. 48-ball FBGA (6 × 8 × 1 mm), 51-85150





51-85150 *F



Acronyms

Acronym	Description				
CMOS	complementary metal oxide semiconductor				
CE	chip enable				
I/O	input/output				
OE	output enable				
SOJ	small outline J-lead				
SRAM	static random access memory				
TSOP	thin small-outline package				
TTL	transistor-transistor logic				
FBGA	fine-pitch ball grid array				
WE	write enable				

Document Conventions

Units of Measure

Symbol	Unit of Measure			
°C	degree Celsius			
μΑ	micro Amperes			
mA	milli Amperes			
mm	milli meter			
mW	milli Watts			
MHz	Mega Hertz			
ns	nano seconds			
pF	pico Farad			
V	Volts			
W	Watts			
%	percent			



Document History Page

	ocument Title: CY7C1021CV26, 1-Mbit (64 K × 16) Static RAM ocument Number: 38-05589					
REV.	ECN NO.	Issue Date	Orig. of Change	Description of Change		
**	238454	See ECN	RKF	New data sheet for Automotive		
*A	335861	See ECN	SYT	Added Lead-Free Product Information Included the 44-Lead (400-Mil) Molded SOJ V34 Package		
*B	493543	See ECN	NXR	Changed the description of I _{IX} from Input Load Current to Input Leakage Current in DC Electrical Characteristics table Removed I _{OS} parameter from DC Electrical Characteristics table Updated Ordering Information Table		
*C	2897087	03/22/10	AJU	Removed obsolete parts from ordering information table Updated package diagrams		
*D	3057593	10/13/2010	PRAS	Updated Ordering Information and added Ordering Code Definitions. Updated Package Diagrams.		
*E	3098812	12/01/2010	PRAS	Added Acronyms and Units of Measure. Minor edits and updated in new template.		
*F	3277371	06/08/2011	AJU	Updated Pin Configuration (Included pin configurations for 44-pin SOJ and 48-ball FBGA packages).		

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